

June/2004

MITSUBISHI SEMICONDUCTOR <GaAs FET>

MGF4953A/MGF4954A

SUPER LOW NOISE InGaAs HEMT (Leadless Ceramic Package)

DESCRIPTION

The MGF4953A/MGF4954A super-low noise HEMT (High Electron Mobility Transistor) is designed for use in C to K band amplifiers.

The lead-less ceramic package assures minimum parasitic losses.

FEATURES

Low noise figure @ f=12GHz
 MGF4953A : NFmin. = 0.40dB (Typ.)
 MGF4954A : NFmin. = 0.60dB (Typ.)

High associated gain @ f=12GHz
 Gs = 13.5dB (Typ.)

APPLICATION

C to K band low noise amplifiers

QUALITY GRADE

GG

RECOMMENDED BIAS CONDITIONS

$V_{DS}=2V$, $I_D=10mA$

ORDERING INFORMATION

Tape & reel 3000pcs./reel

Outline Drawing

Fig.1

MITSUBISHI Proprietary

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ABSOLUTE MAXIMUM RATINGS ($T_a=25^{\circ}C$)

Symbol	Parameter	Ratings	Unit
V_{GDO}	Gate to drain voltage	-4	V
V_{GSO}	Gate to source voltage	-4	V
I_D	Drain current	60	mA
PT	Total power dissipation	50	mW
T_{ch}	Channel temperature	125	$^{\circ}C$
T_{stg}	Storage temperature	-65 to +125	$^{\circ}C$

Keep Safety first in your circuit designs!

Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measure such as (i) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

ELECTRICAL CHARACTERISTICS ($T_a=25^{\circ}C$)

Symbol	Parameter	Test conditions	Limits			Unit
			MIN.	TYP.	MAX	
$V_{(BR)GDO}$	Gate to drain breakdown voltage	$I_G=-10\mu A$	-3	--	--	V
I_{GSS}	Gate to source leakage current	$V_{GS}=-2V, V_{DS}=0V$	--	--	50	μA
I_{DSS}	Saturated drain current	$V_{GS}=0V, V_{DS}=2V$	15	--	60	mA
$V_{GS(off)}$	Gate to source cut-off voltage	$V_{DS}=2V, I_D=500\mu A$	-0.1	--	-1.5	V
gm	Transconductance	$V_{DS}=2V, I_D=10mA$	--	70	--	mS
Gs	Associated gain	$V_{DS}=2V,$	12.0	13.5	--	dB
NFmin.	Minimum noise figure	$I_D=10mA$	--	0.40	0.50	dB
		f=12GHz				

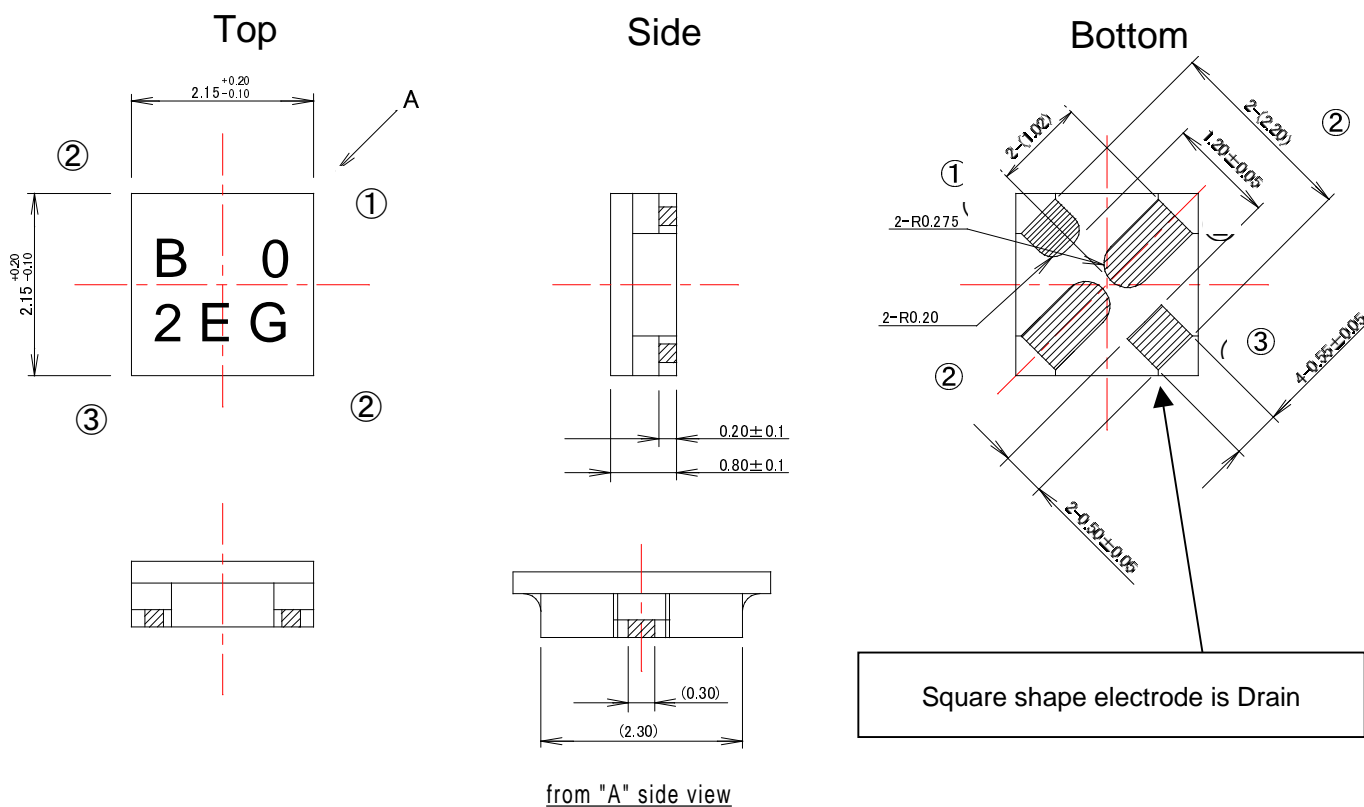
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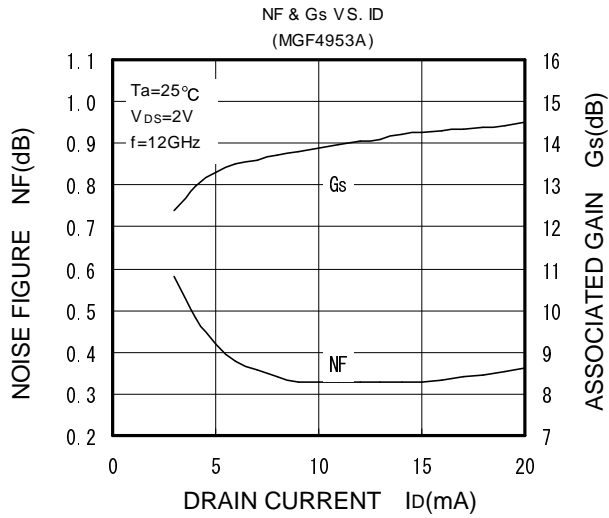
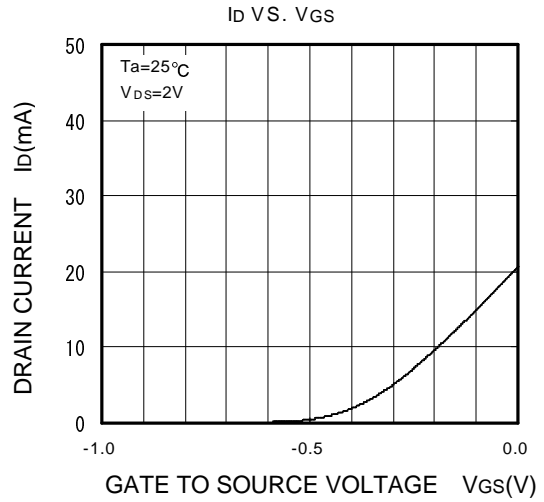
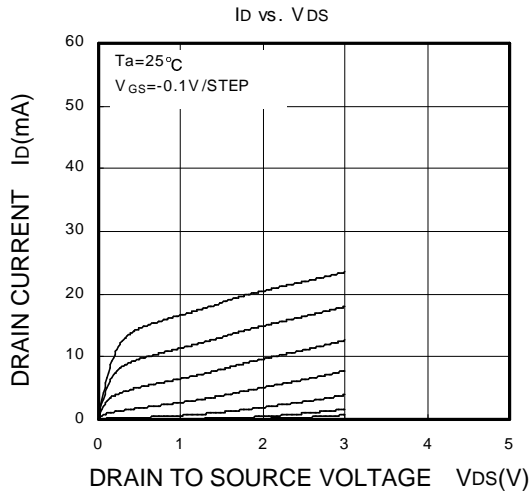
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Fig.1

Unit : mm



TYPICAL CHARACTERISTICS (Ta=25°C)



S PARAMETERS

(Ta=25°C, VDS=2V, ID=10mA)

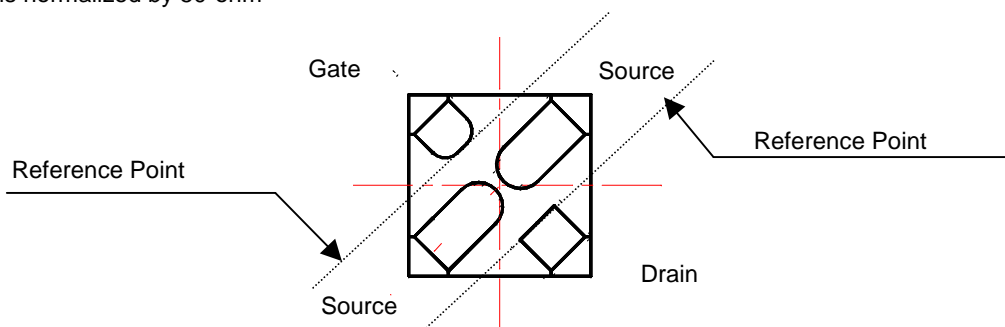
Freq (GHz)	S11		S21		S12		S22	
	(mag)	(ang)	(mag)	(ang)	(mag)	(ang)	(mag)	(ang)
1	0.911	-12.7	4.924	168.1	0.008	70.3	0.709	-10.7
2	0.894	-29.2	4.806	155.3	0.031	68.8	0.691	-22.7
3	0.875	-40.7	4.796	142.7	0.043	62.2	0.682	-30.1
4	0.858	-53.9	4.672	131.6	0.061	49.4	0.652	-41.7
5	0.830	-66.5	4.524	121.2	0.066	42.9	0.639	-49.6
6	0.797	-77.7	4.308	109.5	0.073	33.5	0.631	-58.5
7	0.770	-87.0	4.114	101.1	0.080	26.2	0.628	-64.4
8	0.751	-94.2	3.984	90.8	0.089	22.1	0.625	-71.0
9	0.727	-103.0	3.886	81.4	0.090	17.4	0.624	-76.1
10	0.713	-110.8	3.881	75.0	0.101	9.2	0.628	-80.4
11	0.686	-119.9	3.886	66.0	0.110	2.2	0.612	-87.5
12	0.636	-132.8	3.937	54.7	0.120	-4.6	0.581	-94.3
13	0.590	-146.6	4.078	45.0	0.127	-13.0	0.540	-101.0
14	0.538	-165.8	4.163	31.5	0.136	-25.2	0.485	-112.5
15	0.507	-170.2	4.239	18.9	0.144	-35.8	0.396	-122.4
16	0.506	140.8	4.238	4.5	0.151	-48.2	0.283	-137.3
17	0.552	110.4	4.067	-10.5	0.151	-62.0	0.159	-162.3
18	0.625	86.0	3.791	-26.5	0.145	-74.0	0.076	120.8
19	0.696	65.9	3.428	-40.5	0.137	-85.8	0.164	54.1
20	0.745	50.8	3.045	-54.3	0.118	-97.6	0.271	31.6
21	0.791	38.2	2.677	-66.5	0.109	-106.8	0.375	20.9
22	0.794	28.2	2.281	-76.2	0.102	-114.0	0.455	14.3
23	0.776	18.4	1.984	-84.5	0.091	-118.9	0.539	8.5
24	0.802	11.0	1.828	-93.8	0.078	-127.7	0.607	5.7
25	0.796	2.9	1.626	-102.1	0.071	-130.2	0.675	2.1
26	0.799	-8.5	1.424	-114.5	0.064	-138.3	0.730	0.9

NOISE PARAMETERS

(Ta=25°C, VDS=2V, ID=10mA)

f (GHz)	Gamma-opt		Rn (ohm)	NFmin. (dB)	Gs (dB)
	Magn.	Angle			
4	0.64	52.7	0.27	0.22	18.3
8	0.61	103.5	0.15	0.28	15.9
12	0.55	146.4	0.06	0.35	13.5
14	0.51	161.9	0.04	0.39	12.5
18	0.41	175.3	0.03	0.48	11.0
20	0.35	-177.3	0.05	0.55	10.5

Note) Rn is normalized by 50-ohm



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